

General features

Type	V_{CES}	$V_{CE(sat)Max @25^\circ C}$	$I_C @100^\circ C$
STGD10NC60KD	600V	<2.5V	10A

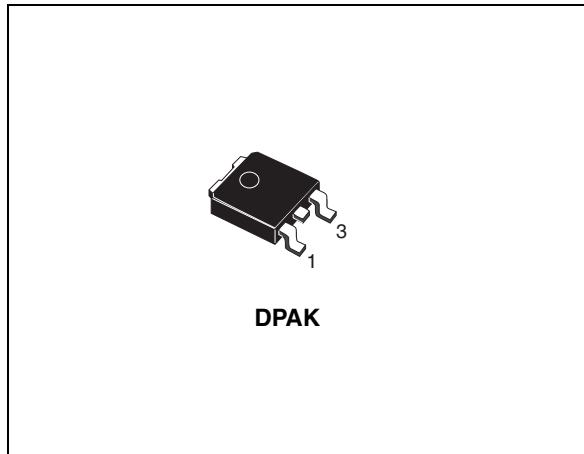
- Lower on voltage drop (V_{cesat})
- Lower C_{RES} / C_{IES} ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode

Description

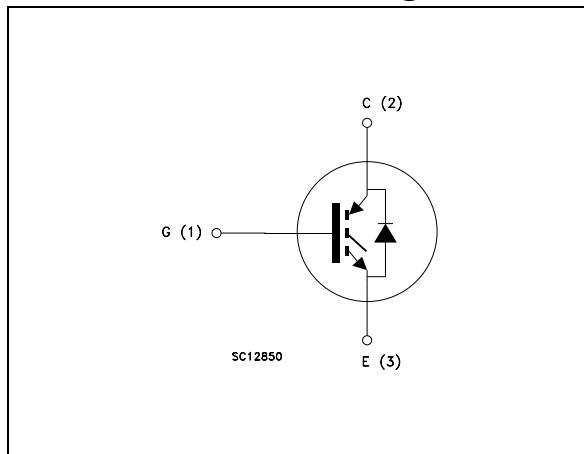
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "K" identifies a family optimized for high frequency motor control applications with short circuit withstand capability.

Applications

- High frequency motor controls
- SMPS and PFC in both hard switch and resonant topologies
- Motor drivers



Internal schematic diagram



Order code

Part number	Marking	Package	Packaging
STGD10NC60KDT4	GD10NC60KD	DPAK	TAPE & REEL

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage ($V_{GS} = 0$)	600	V
$I_C^{(1)}$	Collector current (continuous) at $T_C = 25^\circ\text{C}$	20	A
$I_C^{(1)}$	Collector current (continuous) at $T_C = 100^\circ\text{C}$	10	A
$I_{CM}^{(2)}$	Collector current (pulsed)	40	A
I_F	Diode RMS forward current at $T_C = 25^\circ\text{C}$	10	A
V_{GE}	Gate-emitter voltage	± 20	V
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$	60	W
T_{stg}	Storage temperature	– 55 to 150	$^\circ\text{C}$
T_j	Operating junction temperature		
T_{scw}	Short circuit withstand time	10	μs
T_l	Maximum lead temperature for soldering purpose (for 10sec. 1.6 mm from case)	300	$^\circ\text{C}$

1. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C, I_C)}$$

2. Pulse width limited by max junction temperature

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	2.08	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient max	62.5	$^\circ\text{C/W}$

2 Electrical characteristics

($T_{CASE}=25^{\circ}\text{C}$ unless otherwise specified)

Table 3. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{BR(CES)}$	Collector-emitter breakdown voltage	$I_C=1\text{mA}, V_{GE}=0$	600			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE}=15\text{V}, I_C=5\text{A}$ $V_{GE}=15\text{V}, I_C=5\text{A}, T_c=125^{\circ}\text{C}$		2 1.8	2.5	V V
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE}=V_{GE}, I_C=250\ \mu\text{A}$	5		7	V
I_{CES}	Collector cut-off current ($V_{GE} = 0$)	$V_{CE}=\text{Max Rating}, T_C=25^{\circ}\text{C}$ $V_{CE}=\text{Max Rating}, T_C=125^{\circ}\text{C}$			10 1	μA mA
I_{GES}	Gate-emitter leakage current ($V_{CE} = 0$)	$V_{GE}=\pm20\text{V}, V_{CE}=0$			±100	nA
g_{fs}	Forward transconductance	$V_{CE} = 15\text{V}, I_C=5\text{A}$		15		s

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance			380		pF
C_{oes}	Output capacitance	$V_{CE} = 25\text{V}, f = 1\text{MHz},$ $V_{GE} = 0$		46		pF
C_{res}	Reverse transfer capacitance			8.5		pF
Q_g	Total gate charge	$V_{CE} = 390\text{V}, I_C = 5\text{A},$		19		nC
Q_{ge}	Gate-emitter charge	$V_{GE} = 15\text{V},$		5		nC
Q_{gc}	Gate-collector charge	(see Figure 17)		9		nC

Table 5. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 18)		17 6 655		ns ns A/ μ s
$t_{d(on)}$ t_r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 18)		16.5 6.5 575		ns ns A/ μ s
$t_r(V_{off})$ $t_d(off)$ t_f	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390V, I_C = 5A, R_{GE} = 10\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 18)		33 72 82		ns ns ns
$t_r(V_{off})$ $t_d(off)$ t_f	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390V, I_C = 5A, R_{GE} = 10\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 18)		60 106 136		ns ns ns

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$ $E_{off}^{(2)}$ E_{ts}	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V, T_j = 25^\circ C$ (see Figure 18)		55 85 140		μJ μJ μJ
$E_{on}^{(1)}$ $E_{off}^{(2)}$ E_{ts}	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V, T_j = 125^\circ C$ (see Figure 18)		87 162 249		μJ μJ μJ

1. E_{on} is the turn-on losses when a typical diode is used in the test circuit in Figure 18. If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature ($25^\circ C$ and $125^\circ C$)
2. Turn-off losses include also the tail of the collector current

Table 7. Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_f	Forward on-voltage	$I_f = 2.5A$ $I_f = 2.5A, T_j = 125^\circ C$		1.6 1.3	2.1	V V
t_{rr} Q_{rr} I_{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_f = 5A, V_R = 30V,$ $T_j = 25^\circ C, di/dt = 100 A/\mu s$ <i>(see Figure 19)</i>		23.5 16.5 1.4		ns nC A
t_{rr} Q_{rr} I_{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_f = 5A, V_R = 30V,$ $T_j = 125^\circ C, di/dt = 100A/\mu s$ <i>(see Figure 19)</i>		39 39 2		ns nC A

2.1 Electrical characteristics (curves)

Figure 1. Output characteristics

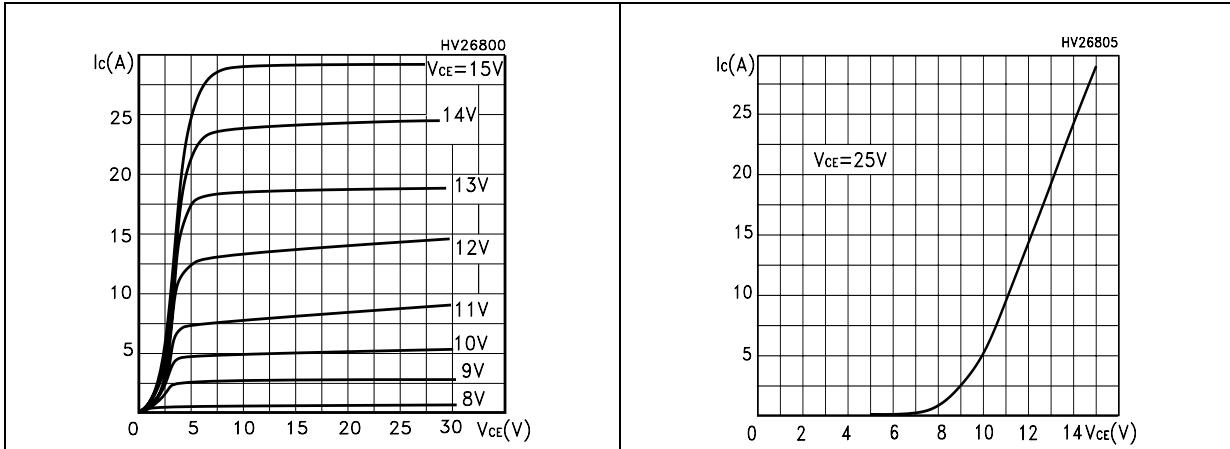


Figure 3. Transconductance

Figure 2. Transfer characteristics

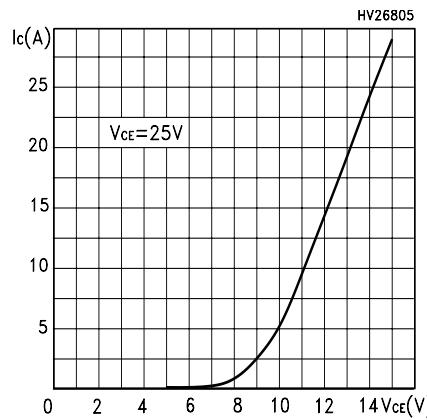


Figure 4. Collector-emitter on voltage vs temperature

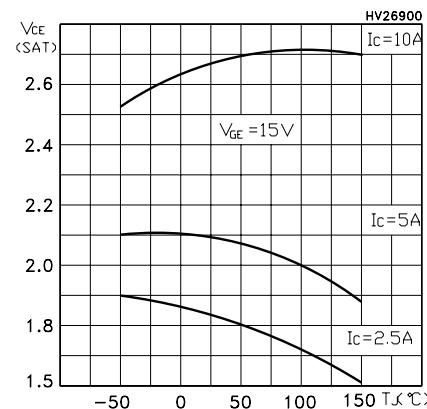
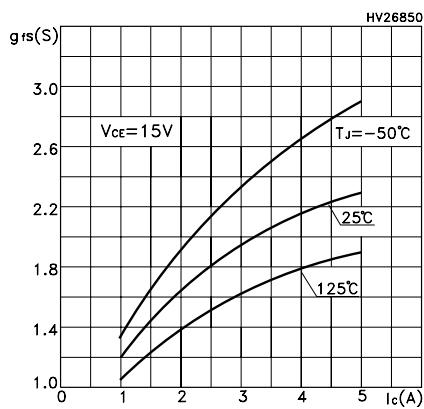


Figure 5. Gate charge vs gate-source voltage

Figure 6. Capacitance variations

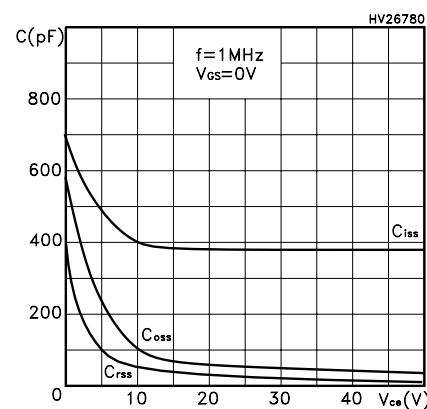
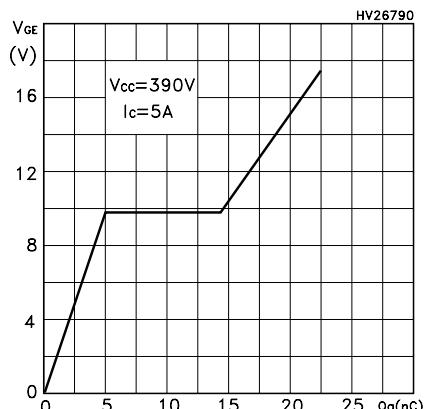


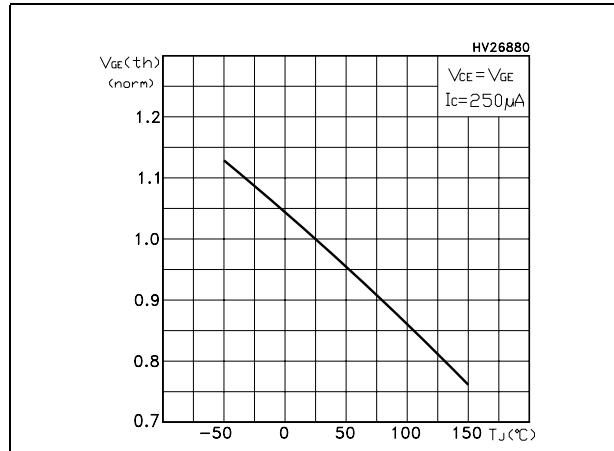
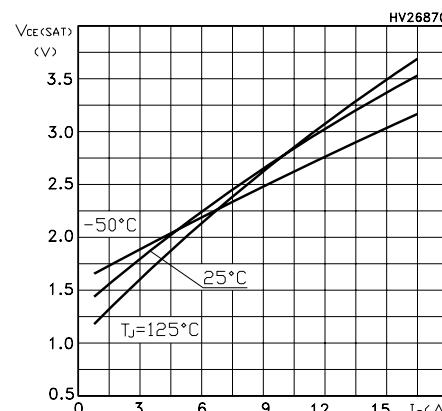
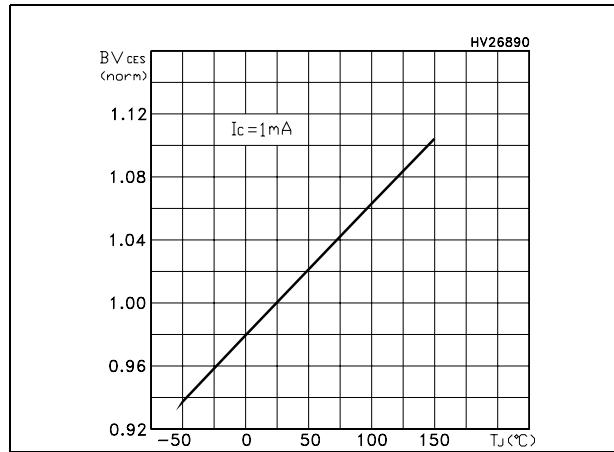
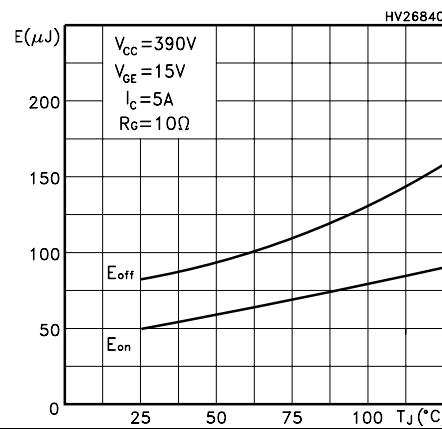
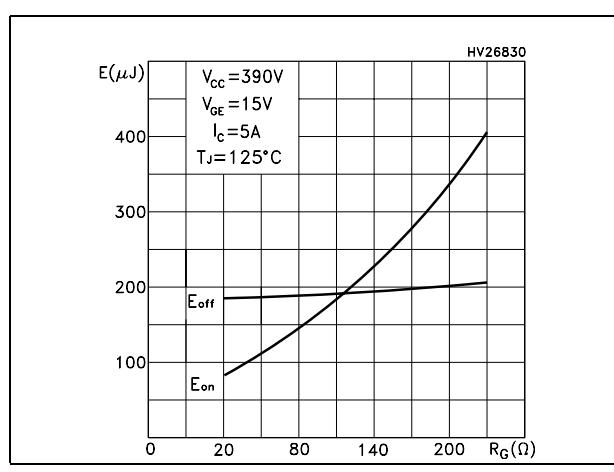
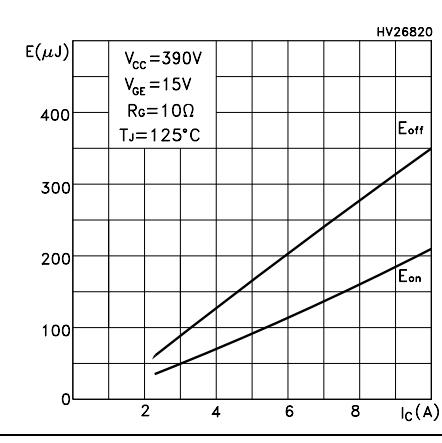
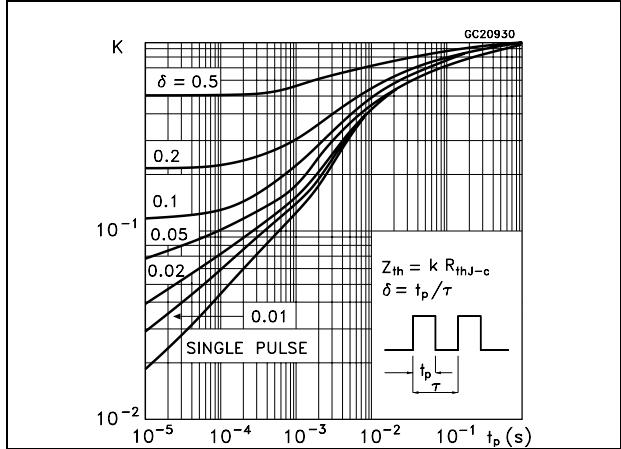
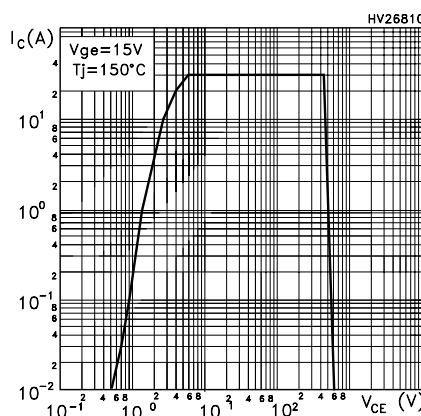
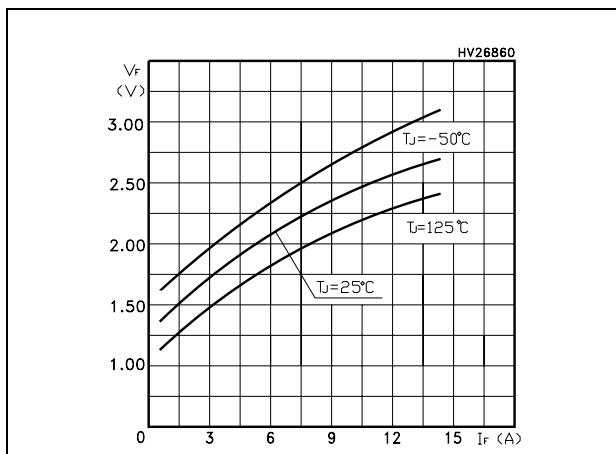
Figure 7. Normalized gate threshold voltage vs temperature**Figure 8. Collector-emitter on voltage vs collector current****Figure 9. Normalized breakdown voltage vs temperature****Figure 10. Switching losses vs temperature****Figure 11. Switching losses vs gate resistance****Figure 12. Switching losses vs collector current**

Figure 13. Thermal Impedance**Figure 14. Turn-off SOA****Figure 15. Emitter-collector diode characteristics**

3 Test circuit

Figure 16. Test circuit for inductive load switching

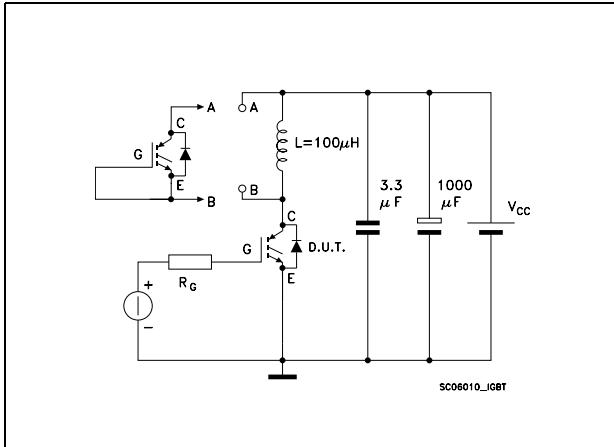


Figure 17. Gate charge test circuit

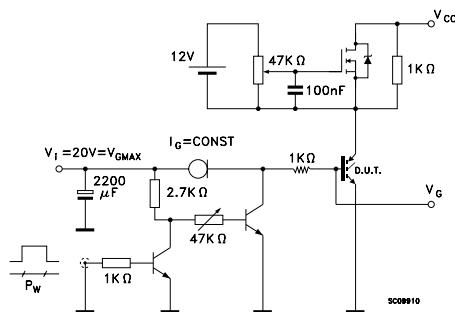


Figure 18. Switching waveform

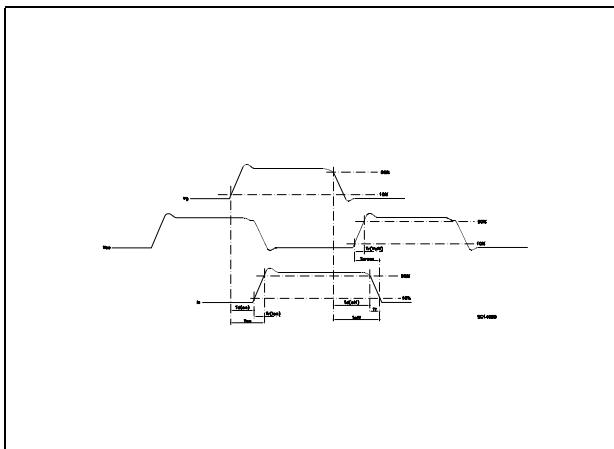
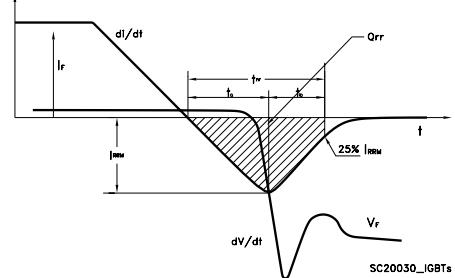


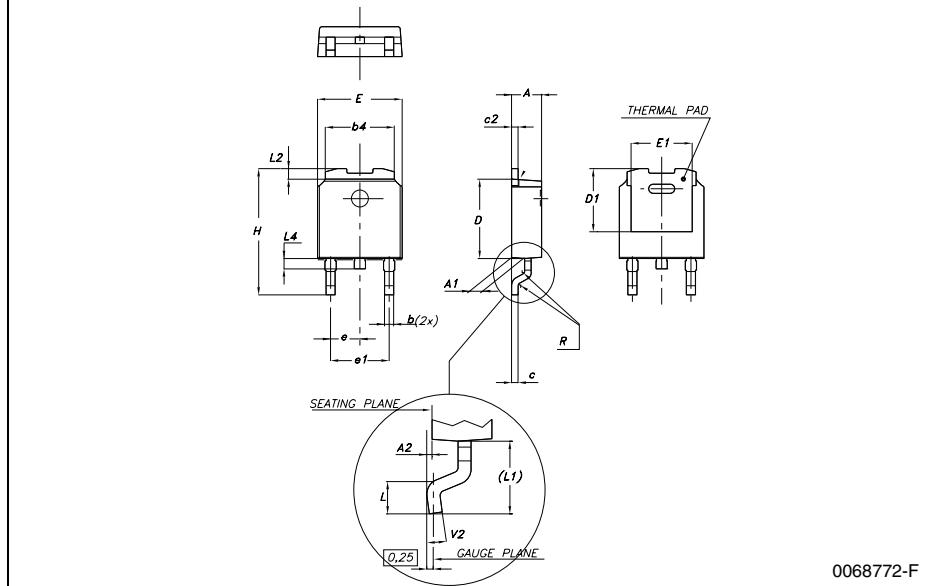
Figure 19. Diode recovery time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

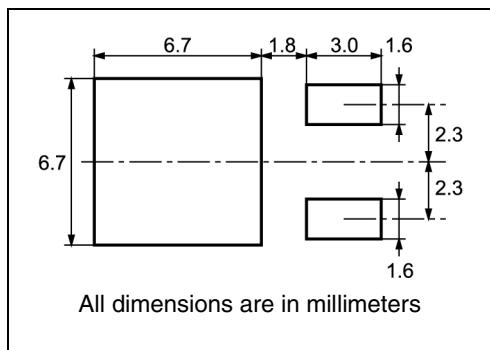
DPAK MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
B	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
e		2.28			0.090	
e1	4.4		4.6	0.173		0.181
H	9.35		10.1	0.368		0.397
L	1		0.039			
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°



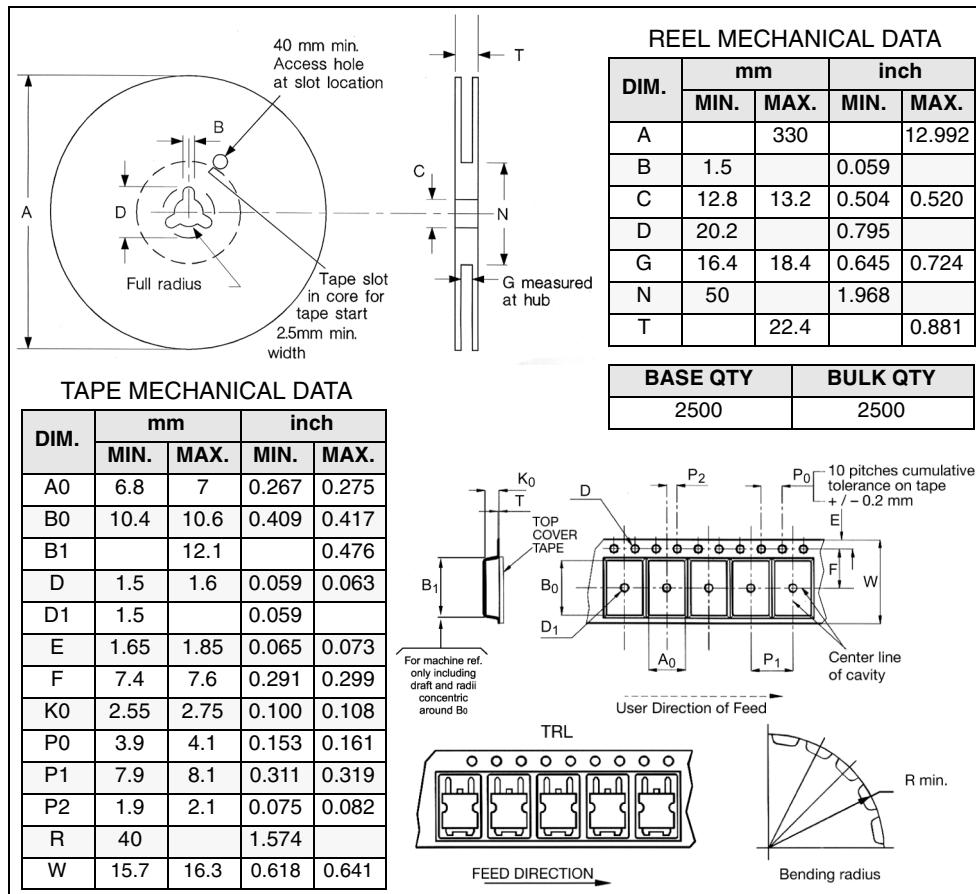
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5 Packaging mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



6 Revision history

Table 8. Revision history

Date	Revision	Changes
02-Feb-2007	1	First release

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